Application/Control No.	Applicant(s)/Patent under Reexamination	
10/644,850	SHINOHARA, MAHITO	
Examiner	Art Unit	
Pritham Prabhakher	2622	

SEARCHED					
Class	Subclass	Date	Examiner		
348	281	5/4/2007	PP		
250	208.1	5/4/2007	PP		
348	308	5/4/2007	PP		
257	292	5/4/2007	PP		
348	302	5/4/2007	PP		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
interferen	rch, see ce search printout	5/4/2007	PP		

SEARCH NOT (INCLUDING SEARCH :)
	DATE	EXMR
On East [US-PGPUB, USPA, USOCR, EPO, JPO, DERWENT, IBM_TDB] SEE SEARCH TERMS ATTACHED]	5/4/2007	PP
Inventor Name Search	5/4/2007	PP
Google Search Terms [JFET and MOSFET]	5/4/2007	PP
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